

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/813,067	FINK, STEVEN T.	
	Examiner	Art Unit	
	Jeffrey Sharp	3677	Page 1 of 3

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	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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